

Notice of References Cited	Application/Control No. 10/784,441	Applicant(s)/Patent Under Reexamination DION ET AL.	
	Examiner Jeffrey G. Hoekstra	Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0072730	06-2002	McGill et al.	604/525
*	B	US-2004/0143283	07-2004	McGill et al.	606/192
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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